			- 	 -			г		heet 1	_01
FORM PTO-1449			U.S. DEPARTMENT OF COMMERCE		ATTY, DOCKET NO.			SERIAL NO.		
			PATENT AND	PATENT AND TRADEMARK OFFICE		026390-00011			New application	
LIST	UE I	PEEEDENCES	CITED BY ADE	CITED BY APPLICANT		APPLICANT				
LIGI	O	VEI EIVEITOEO	OHEDBIAH			M. HIRAKAWA et al. FILING DATE GROUP				
		(Use several she	ets if necessary)					GROUP		
						September 17, 2003		Not Assigned		
			U.S. PA	ATENT DOCUMENT	s					
EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME		CLASS	SUB- CLASS		FILING DATE	
	AA									
	AB									
	AC									
	AD							1		
	AE							1		
	AF			1				+-		
						L	L	٠		
		r- 	FOREIGN	PATENT DOCUME	NTS	· · · · · ·				
		DOCUMENT NO.	DATE	COUNTR	RY	CLASS	SUB- CLASS	TRA YES	NSLAT	ION ART.
W/	AG	2001-288625	10/19/01	Japan				х		
	АН									<u></u>
	Al			 						
	AJ			+						
		1	l .							
	ΔK			1			- 1	١ ١		
	AK									1
	AK AL									
		OTHER REF	ERENCES (Includ	ling Author, Title, Da	te, Pertinent i	Pages, Etc	c.)			
	AL	OTHER REF	ERENCES (Includ	ling Author, Title, Da	te, Pertinent I	Pages, Etc	c.)			
		OTHER REF	ERENCES (Includ	ling Author, Title, Da	te, Pertinent I	Pages, Etc	c.)			
	AM	OTHER REF	ERENCES (Includ	ling Author, Title, Da		Pages, Etc	c.)			
	AL	OTHER REF	ERENCES (Includ	ling Author, Title, Da			c.)			
	AM	OTHER REF	ERENCES (Includ	ling Author, Title, Da			c.)			_

EXAMINER	Way May	DATE CONSIDERED 8/14/05
*EXAMINER:	Initial if reference considered, whether or not citation is in	n conformance with MPEP 609; Draw line through citation if not in

•